

Search Notes**Application/Control No.**

10/644,804

Examiner

Gopal C. Ray

Applicant(s)/Patent under Reexamination

CHEN, CHIH-JU

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner
710	300-303,62,74, 313,316	1/20/2006	GCR
711	100,103	1/20/2006	GCR
361	684,686	1/20/2006	GCR
361	737	1/20/2006	GCR
439	59,79,945	1/20/2006	GCR
439	638,639	1/20/2006	GCR

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	1/20/2006	GCR
EAST: USPT (see search history printouts)	1/20/2006	GCR
NPL: IEEE Xplore (see search history printouts)	1/20/2006	GCR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB text search - see interference search		1/20/2006	GCR